

Application No. 10/373,394
Amendment and Interview Summary

REMARKS

Applicants thank the Examiners for the interview of December 7, 2005. As the interview summary states, agreement to the claims was reached to allow the claims if and when a declaration about particle size was filed. The only amendments in this Response are to claim 20 which correct typographical errors. The substantive matters of the claims have not been amended and were pending at the time of the interview.

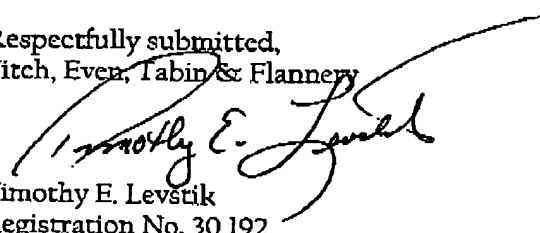
Attached hereto is a declaration under § 1.132. Applicants and the Examiners discussed the 132 declaration at the interview.

Applicants contemporaneously file herewith a Supplemental Information Disclosure Statement to make sure all art of which the Examiner was aware during the interview was "officially cross cited" in each of the applications interviewed on December 7. This application is a Continuation-in-Part Application of Application Serial No. 10/304,446. All of the references cited on the attached Information Disclosure Statement were cited in the Parent Application (Serial No. 10/304,446) or in SN 10/373,394. Only four references (US Publication Nos. 2003/0008037 and 2003/0008038 to Valenzky; US Publication No. 2003/0077356 to Campbell; and US Patent No. 6,139,885 to Jouanneau) are being cited from SN 10/373,394 and they are of marginal relevance.

Applicants respectfully submit with this amendment and 132 declaration that the claims patentably define the invention over the references and requests that a timely Notice of Allowance be issued in this case.

The Commissioner is hereby authorized to charge any additional fees which may be required in this application to Deposit Account No. 06-1135.

Respectfully submitted,
Fitch, Even, Tabin & Flannery


Timothy E. Levstik
Registration No. 30,192

Date: **JAN 09 2006**

Fitch, Even, Tabin & Flannery
120 S. LaSalle St., Suite 1600
Chicago, Illinois 60603
Telephone: (312) 577-7000
Facsimile: (312) 577 7007